Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/995,149	ARCHER ET AL.	
Examiner	Art Unit	
CHUONG T. HO	2616	

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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WEST (Text rearch, Class rearch) EAST STN	01/23/07	CI		
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